

<b>Notice of References Cited</b>	Application/Control No. 10/673,549	Applicant(s)/Patent Under Reexamination SAWADA ET AL.	
	Examiner Marcus Charles	Art Unit 3682	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,157,884	12-2000	Narita et al.	701/51
*	B	US-6,721,643	04-2004	Hanggi et al.	474/28
*	C	US-2004/0059489	03-2004	Hanggi et al.	701/051
*	D	US-6,083,138	07-2000	Aoyama et al.	477/5
*	E	US-7,065,441	06-2006	Yamamoto et al.	477/44
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP (05-332445) A	02-1993	Japan	Okado et al.	477/46
	O	JP (08-177540) A	07-1996	Japan	Hattori et al.	F02D 29/00
	P	JP (11-20513) A	01-1999	Japan	Ochiai et al.	B60K 41/12
	Q	EP (1236935) A2	09-2002	European	Nisizawa et al.	F16H 61/00
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.